

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10509753	YAMAWAKI ET AL.
	Examiner	Art Unit
	Chen, Junpeng	2631

SEARCHED

Class	Subclass	Date	Examiner
455	39,126, 295, 522	02/03/2007	J.C.
331	135		
375	332, 376,297,345,		
330	129,51,285		

SEARCH NOTES

Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PGPub, DERWENT, EPO, JPO and IBM_TDB	05/04/2006	J.C.
Consulted with Nguyen Vo and Quochien Vuong	05/09/2006	J.C.
Googled "second order lag lead filter"	02/03/2007	J.C.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner